

1. Description

MP3205, the silicon N-channel Enhanced MOSFETs, is obtained by advanced MOSFET technology which reduce the conduction loss, improve switching performance and enhance the avalanche energy. The transistor is suitable device for Synchronous Rectification, inverter systems, high speed switching and general purpose applications.

KEY CHARACTERISTICS

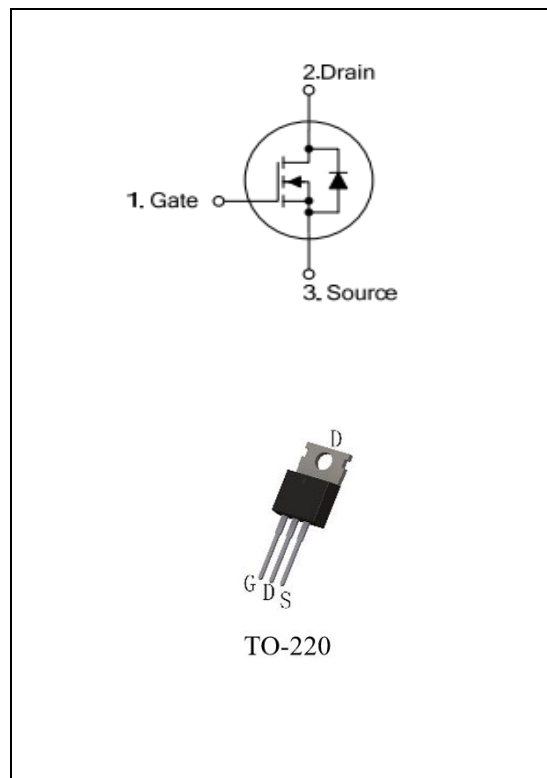
Parameter	Value	Unit
V_{DS}	55	V
I_D	110	A
$R_{DS(ON).Typ}$	7.2	m Ω

FEATURES

- Fast Switching
- Low C_{rss}
- 100% avalanche tested
- Improved dv/dt capability
- RoHS product

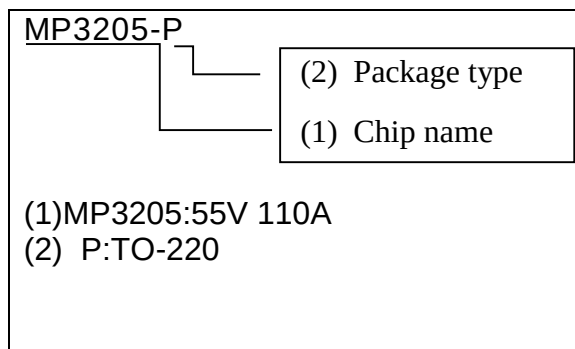
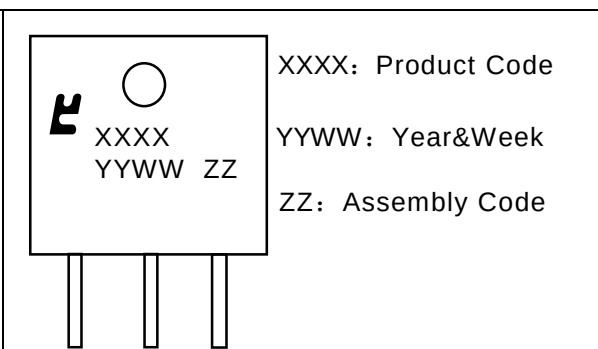
APPLICATIONS

- Power management for 12V inverter systems
- Synchronous Rectification



ORDERING INFORMATION

Ordering Codes	Package	Product Code	Packing
MP3205-P	TO-220	3205	Tube

<p>MP3205-P</p>  <p>(1)MP3205:55V 110A (2) P:TO-220</p>	 <p>XXXX: Product Code YYWW: Year&Week ZZ: Assembly Code</p>
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2. ABSOLUTE RATINGS

at $T_C = 25^\circ\text{C}$, unless otherwise specified

Symbol	Parameter	Rating	Units
V_{DSS}	Drain-to-Source Voltage	55	V
I_D	Continuous Drain Current	110	A
	Continuous Drain Current $T_C = 100^\circ\text{C}$	80	A
I_{DM}	Pulsed Drain Current(Note1)	440	A
V_{GS}	Gate-to-Source Voltage	± 20	V
E_{AS}	Single Pulse Avalanche Energy(Note2)	1500	mJ
I_{AR}	Avalanche Current	25	A
E_{AR}	Repetitive Avalanche Current	20	mJ
dv/dt	Peak Diode Recovery dv/dt (Note3)	5.0	V/ns
P_D	Power Dissipation TO-220	210	W
	Derating Factor above 25°C	1.25	W/ $^\circ\text{C}$
T_J, T_{stg}	Operating Junction and Storage Temperature Range	175, -55 to 175	$^\circ\text{C}$
T_L	Maximum Temperature for Soldering	300	$^\circ\text{C}$

3. Thermal characteristics

Thermal characteristics (No FullPAK) TO-220\TO-3PN

Symbol	Parameter	RATINGS	Units
$R_{\theta JC}$	Junction-to-Case	0.75	$^\circ\text{C}/\text{W}$
$R_{\theta JA}$	Junction-to-Ambient	62.5	$^\circ\text{C}/\text{W}$

4. Electrical Characteristics

at $T_C = 25^\circ\text{C}$, unless otherwise specified

OFF Characteristics						
Symbol	Parameter	Test Conditions	Values			Units
			Min.	Typ.	Max.	
V_{DSS}	Drain to Source Breakdown Voltage	$V_{GS}=0V$, $I_D=250\mu A$	55	--	--	V
$\Delta BV_{DSS}/\Delta T_J$	Bvdss Temperature Coefficient	$I_D=250\mu A$, Reference 25°C	--	0.055	--	$V/^\circ\text{C}$
I_{DSS}	Drain to Source Leakage Current	$V_{DS}=55V$, $V_{GS}=0V$, $T_J=25^\circ\text{C}$	--	--	1	μA
		$V_{DS}=44V$, $V_{GS}=0V$, $T_J=125^\circ\text{C}$	--	--	10	μA
$I_{GSS(F)}$	Gate to Source Forward Leakage	$V_{GS}=+20V$	--	--	100	nA
$I_{GSS(R)}$	Gate to Source Reverse Leakage	$V_{GS}=-20V$	--	--	100	nA

ON Characteristics						
Symbol	Parameter	Test Conditions	Values			Units
			Min.	Typ.	Max.	
$R_{DS(ON)}$	Drain-to-Source On-Resistance	$V_{GS}=10V$, $I_D=40A$	--	7.2	9	$m\Omega$
$V_{GS(TH)}$	Gate Threshold Voltage	$V_{DS}=V_{GS}$, $I_D=250\mu A$	2	--	4	V
g_{fs}	Forward Transconductance	$V_{DS}=20V$, $I_D=40A$ (Note4)	--	65	--	S

Dynamic Characteristics						
Symbol	Parameter	Test Conditions	Values			Units
			Min.	Typ.	Max.	
R_g	Gate resistance	$f=1.0\text{MHz}$	--	1.7	--	Ω
C_{iss}	Input Capacitance	$V_{GS}=0V$ $V_{DS}=25V$ $f=1.0\text{MHz}$	--	3247	--	PF
C_{oss}	Output Capacitance		--	781	--	
C_{rss}	Reverse Transfer Capacitance		--	211	--	

Switching Characteristics						
Symbol	Parameter	Test Conditions	Values			Units
			Min.	Typ.	Max.	
$t_{d(ON)}$	Turn-on Delay Time	$I_D = 62A$ $V_{DD} = 28V$ $V_{GS} = 10V$ $R_G = 4.5\Omega$	--	14	--	ns
t_r	Rise Time		--	101	--	
$t_{d(OFF)}$	Turn-Off Delay Time		--	50	--	
t_f	Fall Time		--	65	--	
Q_g	Total Gate Charge	$I_D = 62A$ $V_{DD} = 44V$ $V_{GS} = 10V$	--	146	--	nC
Q_{gs}	Gate to Source Charge		--	10	--	
Q_{gd}	Gate to Drain ("Miller") Charge		--	17.5	--	

Source-Drain Diode Characteristics						
Symbol	Parameter	Test Conditions	Values			Units
			Min.	Typ.	Max.	
I_S	Continuous Source Current (Body Diode)	$TC = 25^\circ C$	--	--	110	A
I_{SM}	Maximum Pulsed Current (Body Diode)		--	--	440	A
V_{SD}	Diode Forward Voltage	$I_S = 62A$, $V_{GS} = 0V$	--	0.9	1.3	V
T_{rr}	Reverse Recovery Time	$I_S = 62A$, $T_j = 25^\circ C$ $dI_F/dt = 100A/\mu s$, $V_{GS} = 0V$	--	69	--	ns
Q_{rr}	Reverse Recovery Charge		--	143	--	nC

Note1: Pulse width limited by maximum junction temperature

Note2: $L = 1mH$, $V_{DS} = 44V$, Start $T_J = 25^\circ C$

Note3: $I_{SD} \leq 110A$, $dI/dt \leq 300A/\mu s$, $V_{DD} \leq BV_{DS}$, Start $T_J = 25^\circ C$

Note4: Pulse width $t_p \leq 300\mu s$, $\delta \leq 2\%$

5. Characteristics Curves

Figure 1 Safe Operating Area

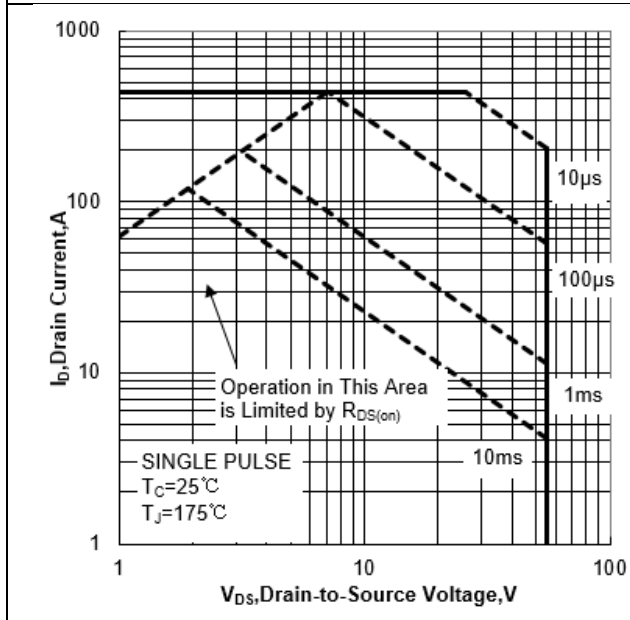


Figure 2 Max Thermal Impedance

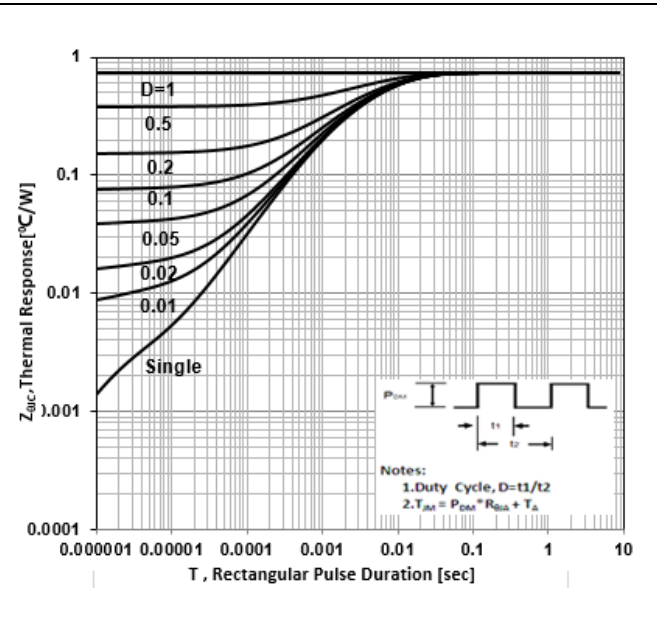


Figure 3 Typical Output Characteristics

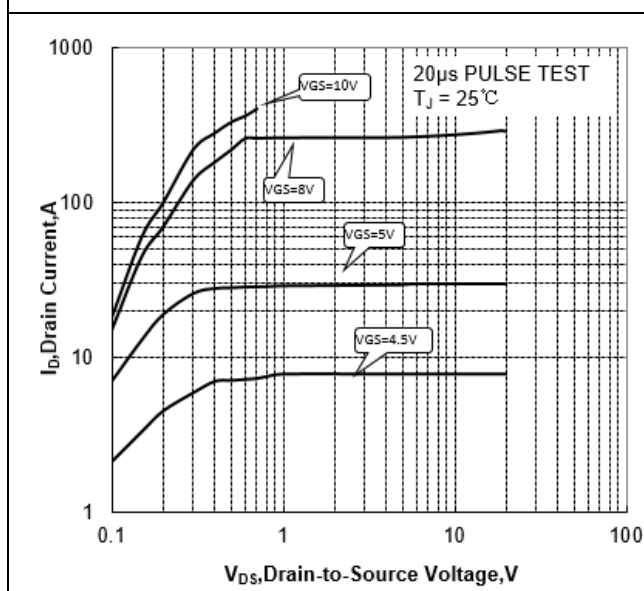


Figure 4 Typical Output Characteristics

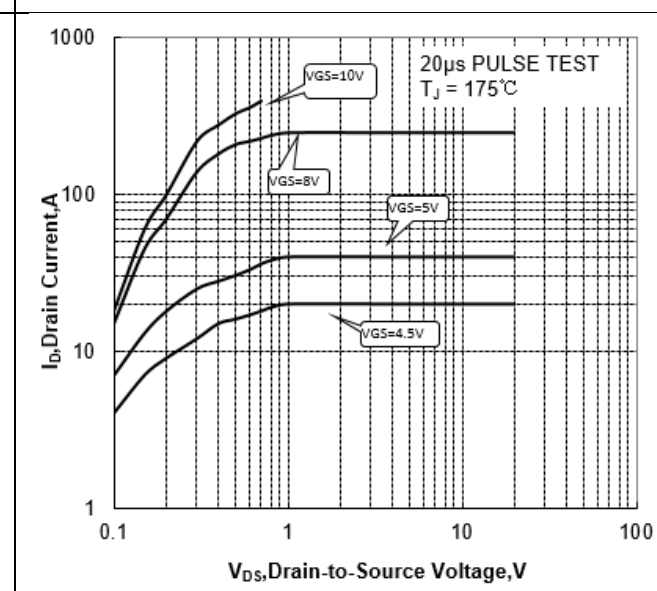


Figure 5 Typical Transfer Characteristics

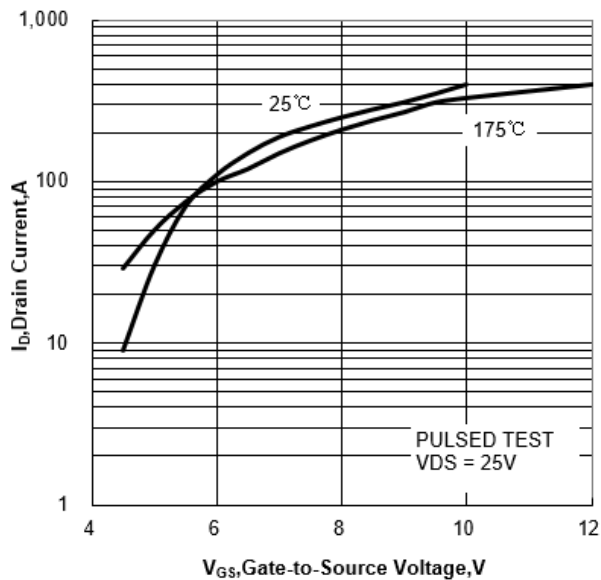


Figure 6 Typical Drain to Source On Resistance vs Junction Temperature

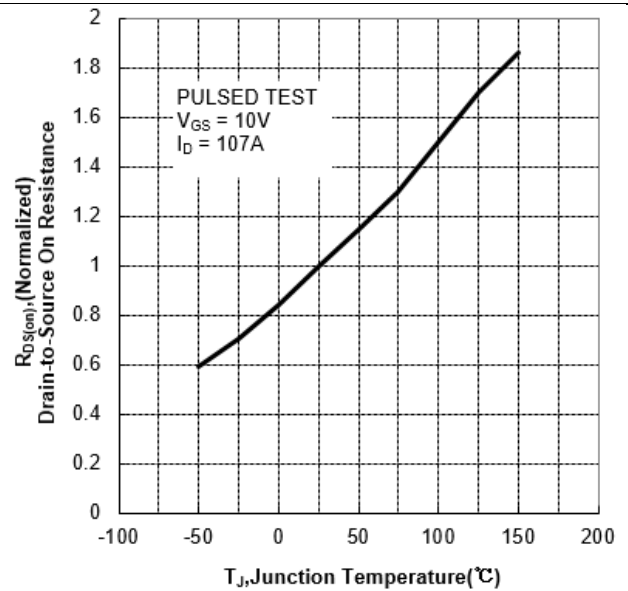


Figure 7 Maximum Drain Current vs Case Temperature

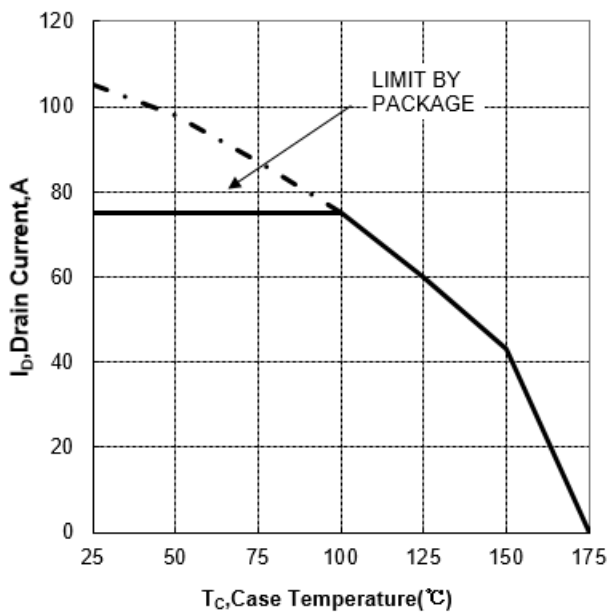


Figure 8 Typical Source-Drain Diode Forward Voltage

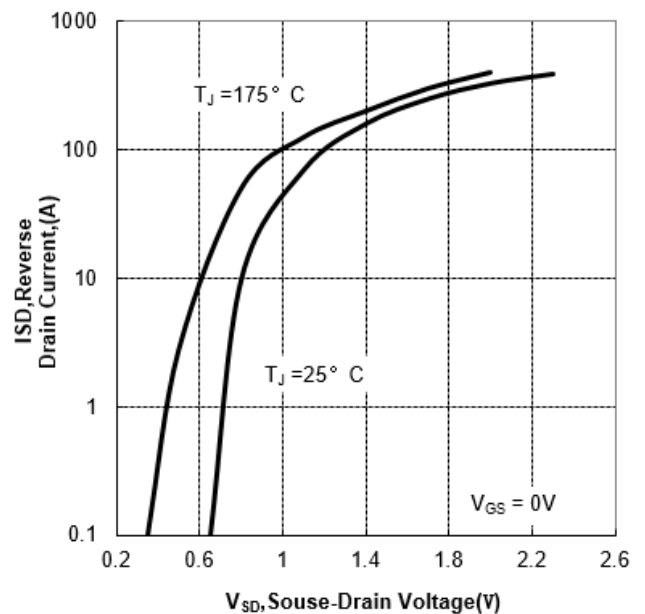


Figure 9 Typical Capacitance vs Drain-to-Source Voltage

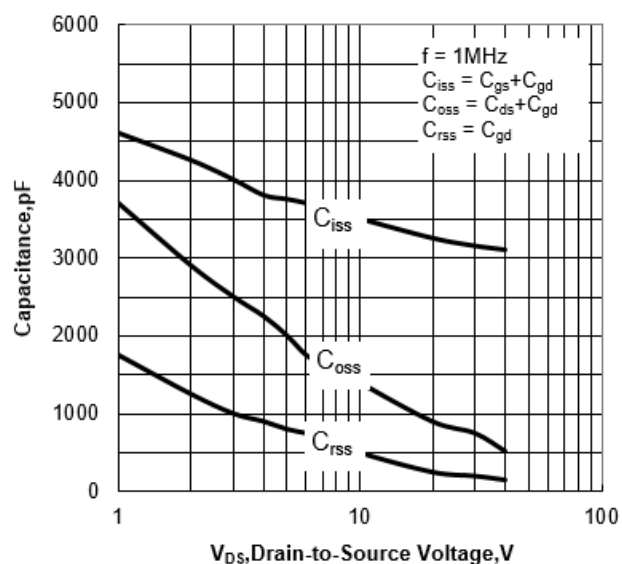
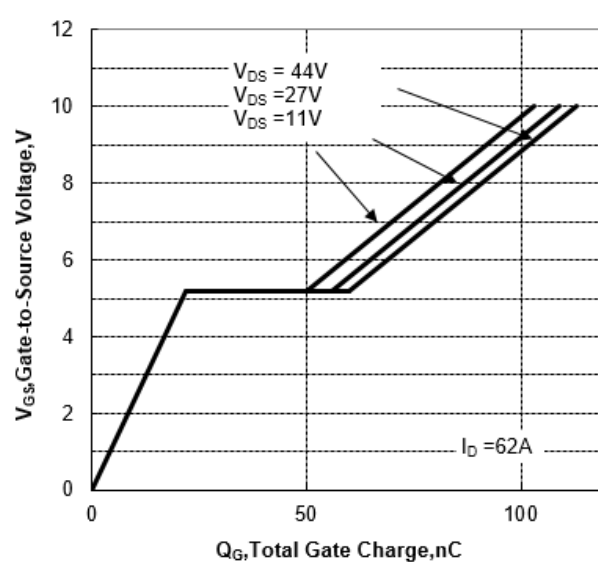


Figure 10 Typical Gate Charge vs Gate-to-Source Voltage



6. Test Circuit and Waveform

Figure 12 Gate Charge Test Circuit

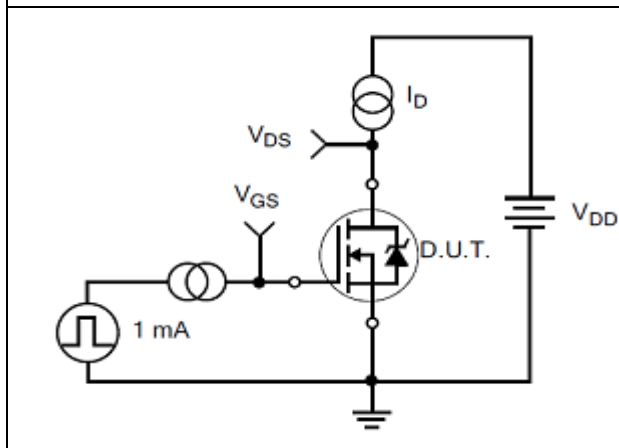


Figure 13 Gate Charge Waveforms

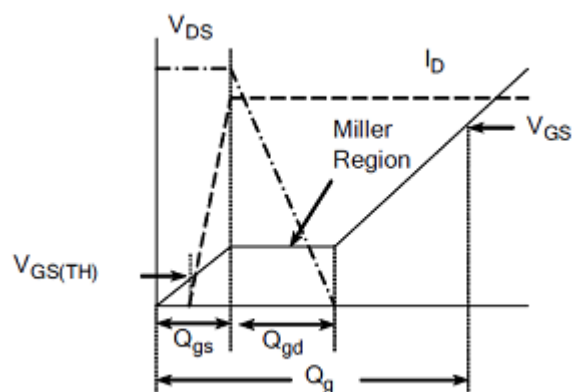


Figure 14 Resistive Switching Test Circuit

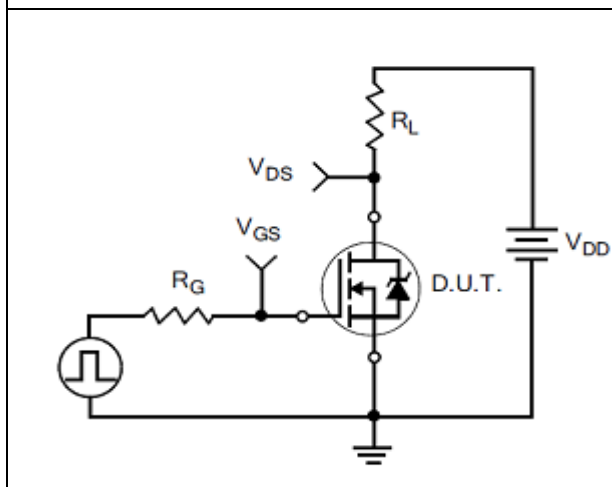


Figure 15 Resistive Switching Waveforms

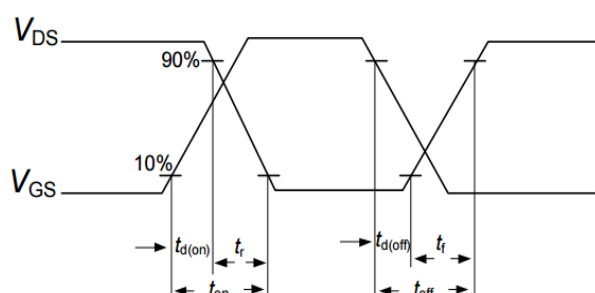


Figure 16 Diode Reverse Recovery Test Circuit

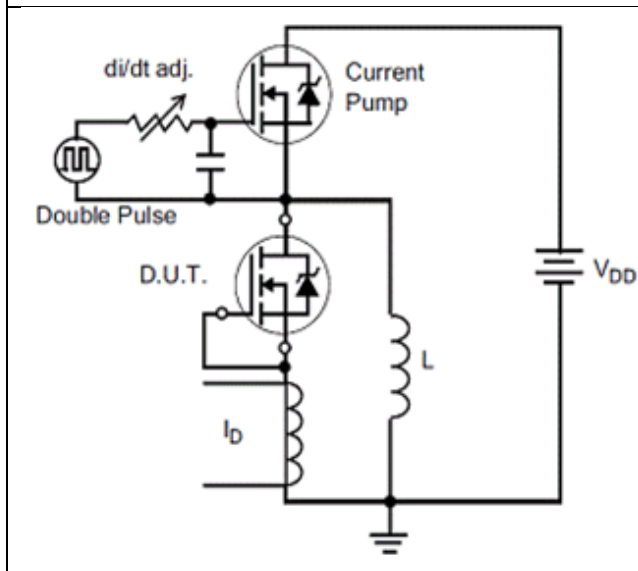


Figure 17 Diode Reverse Recovery Waveform

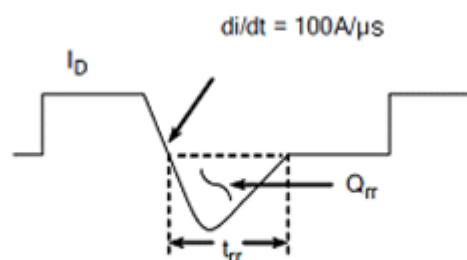


Figure 18 Unclamped Inductive Switching Test Circuit

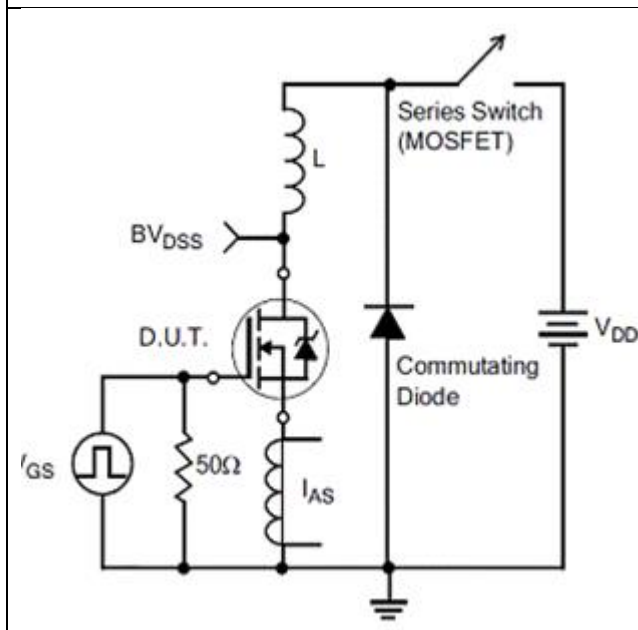
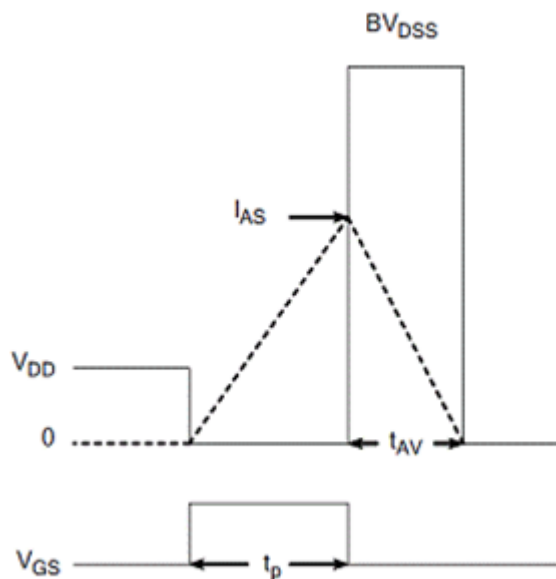
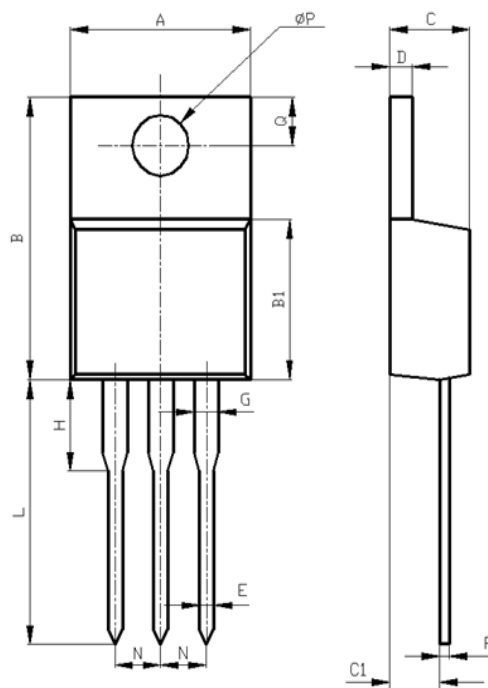


Figure 19 Unclamped Inductive Switching Waveform



7. Package Description



Items	Values(mm)	
	MIN	MAX
A	9.60	10.6
B	15.0	16.0
B1	8.90	9.50
C	4.30	4.80
C1	2.30	3.10
D	1.20	1.40
E	0.70	0.90
F	0.30	0.60
G	1.17	1.37
H	2.70	3.80
L	12.6	14.8
N	2.34	2.74
Q	2.40	3.00
Ø P	3.50	3.90

TO-220 Package

NOTE:

1. Exceeding the maximum ratings of the device in performance may cause damage to the device, even the permanent failure, which may affect the dependability of the machine. Please do not exceed the absolute maximum ratings of the device when circuit designing.
2. When installing the heat sink, please pay attention to the torsional moment and the smoothness of the heat sink.
3. MOSFETs is the device which is sensitive to the static electricity, it is necessary to protect the device from being damaged by the static electricity when using it.
4. Shenzhen Minos reserves the right to make changes in this specification sheet and is subject to change without prior notice.

CONTACT:

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